

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

PATENT

In re application of: Kapre, et al

Attorney Docket No.: 01-721/LSI1P185

Application No.: 10/020,304

Examiner: Sefer, Ahmed N.

Filed: December 13, 2001

Group: 2826

Title: BURIED CHANNEL DEVICES AND A PROCESS FOR THEIR FABRICATION SIMULTANEOUSLY WITH SURFACE CHANNEL DEVICES TO PRODUCE TRANSISTORS AND CAPACITORS WITH MULTIPLE ELECTRICAL GATE OXIDES

CERTIFICATE OF MAILING

I hereby certify that this correspondence is being deposited with the United States Postal Service as First Class Mail to: Commissioner for Patents, Washington, DC 20231 on November 22, 2002.

AMENDMENT B

Commissioner for Patents Washington, D.C. 20231

Dear Sir:

2800 MAIL RO

This amendment and the enclosed remarks are submitted in response teache Non-Final Office Action mailed on July 22, 2002. Applicants respectfully request reconsideration of the captioned application in view of the following remarks and amendments.

In the Claims:

Please amend the claims as follows (a version of the amended claims showing the changes made accompanies this response in an Appendix):

1. (Once Amended) In a semiconductor device having at least an insulating gate dielectric layer and a gate fabricated upon a semiconductor substrate, a buried channel implanted below the insulating gate dielectric layer, the buried channel being doped with a predetermined dopant and a peak concentration of the dopant positioned at a

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12/02/2002 UABDELR1 00000064 10020304